

Notice of References Cited	Application/Control No. 10/565,629		Applicant(s)/Patent Under Reexamination RUNGE ET AL.	
	Examiner NAM HUYNH		Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0034971	03-2002	CHANG et al.	455/569
*	B	US-2004/0204074	10-2004	Desai, Nimesh R.	455/557
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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